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DATE MAILED: 09/20/2005

APPLICATION NO.	F	ILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/708,224		02/18/2004	Masuhiro Natsuhara	39.033	2223
29453	7590	09/20/2005		EXAMINER	
JUDGE PA	TENT F	IRM	PAIK, SANG YEOP		
RIVIERE S 3-1 WAKA		WA 3RD FL. CHO	ART UNIT	PAPER NUMBER	
NISHINOM			3742		
JAPAN		•			_

Please find below and/or attached an Office communication concerning this application or proceeding.

		Appli	cation No.	Applicant(s)					
Office Action Summary			08,224	NATSUHARA ET	NATSUHARA ET AL.				
			niner	Art Unit					
		Sang	Y. Paik	3742					
Period fo	The MAILING DATE of this commun	nication appears of	n the cover sheet v	with the correspondence a	ddress				
A SH WHIC - Exte after - If NC - Failu Any	ORTENED STATUTORY PERIOD FOR CHEVER IS LONGER, FROM THE MODEL IN THE M	MAILING DATE Of s of 37 CFR 1.136(a). In munication. tatutory period will apply a y will, by statute, cause the	F THIS COMMUN no event, however, may a and will expire SIX (6) MO are application to become A	IICATION. The reply be timely filed ONTHS from the mailing date of this (ABANDONED) (35 U.S.C. § 133).					
Status									
1)	Responsive to communication(s) fil	ed on <i>05 Septemb</i>	ber 2005.						
<b>'</b> —	•	2b)⊠ This action							
• —	Since this application is in condition for allowance except for formal matters, prosecution as to the merits								
-,-	closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.								
Disposit	on of Claims								
4) 🖂	Claim(s) 1-4 is/are pending in the a	pplication.							
,	4a) Of the above claim(s) is/are withdrawn from consideration.								
	Claim(s) is/are allowed.								
<u> </u>	Claim(s) <u>1-4</u> is/are rejected.								
·	Claim(s) is/are objected to.								
·	Claim(s) are subject to restri	ction and/or electi	on requirement.						
Applicat	on Papers								
9)	The specification is objected to by the	ne Examiner							
,			or b) objected to	by the Examiner.					
. • / 🗀	) ☐ The drawing(s) filed on is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.  Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).								
	Replacement drawing sheet(s) including				OFR 1.121(d).				
11)	The oath or declaration is objected t	•	•						
·	ınder 35 U.S.C. § 119								
12)	Acknowledgment is made of a claim	for foreign priority	y under 35 U.S.C.	§ 119(a)-(d) or (f).					
a)	☐ All b)☐ Some * c)☐ None of:		baaa saasii sad						
	1. Certified copies of the priority			Application No.					
	2. Certified copies of the priority				J. Ctoops				
	3. Copies of the certified copies			n received in this Nationa	ı Stage				
* 0	application from the Internation	·	• • • •	at received					
	See the attached detailed Office action	on for a list of the	certined copies no	n received.					
Attachmen									
·	e of References Cited (PTO-892)  e of Draftsperson's Patent Drawing Review (	PTO-0481	, <del></del>	Summary (PTO-413) o(s)/Mail Date					
3) 🔲 Infori	e of Draftsperson's Patent Drawing Review (Ination Disclosure Statement(s) (PTO-1449 of No(s)/Mail Date			Informal Patent Application (PT	<sup>-</sup> O-152)				
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## **DETAILED ACTION**

## Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claims 1-4 are rejected under 35 U.S.C. 103(a) as being unpatentable over Kobayashi (US 6,071,465).

Kobayashi shows a semiconductor manufacturing device including a substrate with a resistive heating element, a substrate-supporting shaft joined to the substrate, wherein each surface of the substrate and the supporting shaft is grinded to have the surface roughness of .1 um and a flatness of .1 um (see column 13, lines 7-11; and Figure 10). But, Kobayashi does not explicitly show the claimed distance where the distance between the central axis of the shaft and the center of the substrate is 5% or less of the diameter of the wafer-carrying side of the substrate.

Kobayashi shows in its drawing figures that the center of the supporting shaft is aligned with the center of the substrate. While the claimed distance is not explicitly disclosed, it would have been obvious to one of ordinary skill in the art to have the center of the supporting shaft be aligned with the center of the substrate within the claimed range to prevent imbalancing of the substrate on the supporting shaft as the substrate is further provided to support a wafer thereon. The balancing of the substrate would be vital for proper processing of the wafer as it needs to be

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properly positioned on the substrate for even heat distribution without being moved more to one side or the other.

Kobayashi further shows that the substrate and the supporting shaft are made of aluminum nitride as that of the disclosed invention, and since Kobayashi shows the same structure as that of the claimed invention, Kobayashi would inherently meet the claimed thermal expansion of coefficient along with the claimed temperature distribution in the wafer-carrying side of the substrate within 1.0%.

## Response to Arguments

Applicant's arguments with respect to claims have been considered but are moot in view 3. of the new ground(s) of rejection.

Any inquiry concerning this communication or earlier communications from the 4. examiner should be directed to Sang Y. Paik whose telephone number is 571-272-4783. The examiner can normally be reached on M-F (9:00-4:00) First Friday Off.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Robin Evans can be reached on 571-272-4777. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

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Sang Y Paik
Primary Examiner
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